Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/734,574	CHO ET AL.	
Examiner	Art Unit	
PHALTBAN	2611	

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	298,295 260,261 296,297	2/2/2007	кт
455	127.1,76	2/2/2007	кт
455	67.1,	2/2/2007	кт
322	104,149	2/2/2007	кт

INT	TERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Search Consult Khanh Tran Duc Nguyen (455)	2/2/2007	7 КТ		
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